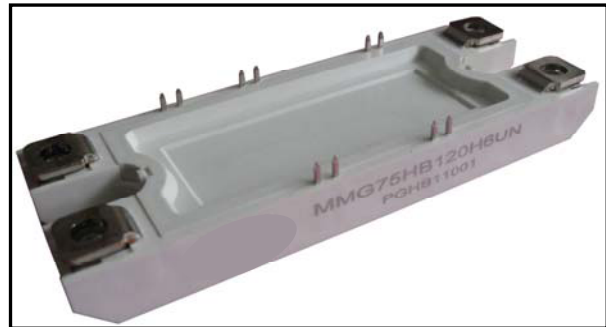


## FEATURES

- High short circuit capability, self limiting short circuit current
- IGBT CHIP(1200V NPT technology)
- $V_{CE(sat)}$  with positive temperature coefficient
- Fast switching and short tail current
- Free wheeling diodes with fast and soft reverse recovery
- Low switching losses



## APPLICATIONS

- High frequency switching application
- Medical applications
- Motion/servo control
- UPS systems

## INVERTER SECTOR

### ABSOLUTE MAXIMUM RATINGS

$T_c=25^\circ\text{C}$  unless otherwise specified

Symbol	Parameter	Test Conditions	Values	Unit
<b>IGBT</b>				
$V_{CES}$	Collector - Emitter Voltage	$T_{vj}=25^\circ\text{C}$	1200	V
$V_{GES}$	Gate - Emitter Voltage		$\pm 20$	V
$I_c$	DC Collector Current	$T_c=25^\circ\text{C}$	100	A
		$T_c=65^\circ\text{C}$	75	A
$I_{CM}$	Repetitive Peak Collector Current	$t_p=1\text{ms}$	150	A
$P_{tot}$	Power Dissipation Per IGBT		480	W
<b>Diode</b>				
$V_{RRM}$	Repetitive Reverse Voltage	$T_{vj}=25^\circ\text{C}$	1200	V
$I_{F(AV)}$	Average Forward Current	$T_c=25^\circ\text{C}$	100	A
		$T_c=65^\circ\text{C}$	75	A
$I_{FRM}$	Repetitive Peak Forward Current	$t_p=1\text{ms}$	150	A
$I^2t$		$T_{vj}=125^\circ\text{C}, t=10\text{ms}, V_R=0\text{V}$	2400	$\text{A}^2\text{s}$

## INVERTER SECTOR

## ELECTRICAL AND THERMAL CHARACTERISTICS

 $T_C=25^{\circ}\text{C}$  unless otherwise specified

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
<b>IGBT</b>						
$V_{GE(th)}$	Gate - Emitter Threshold Voltage	$V_{CE}=V_{GE}, I_C=3.0\text{mA}$	4.5	5.5	6.5	V
$V_{CE(sat)}$	Collector - Emitter Saturation Voltage	$I_C=75\text{A}, V_{GE}=15\text{V}, T_{VJ}=25^{\circ}\text{C}$		3.2		V
		$I_C=75\text{A}, V_{GE}=15\text{V}, T_{VJ}=125^{\circ}\text{C}$		3.85		V
$I_{CES}$	Collector Leakage Current	$V_{CE}=1200\text{V}, V_{GE}=0\text{V}, T_{VJ}=25^{\circ}\text{C}$			1	mA
		$V_{CE}=1200\text{V}, V_{GE}=0\text{V}, T_{VJ}=125^{\circ}\text{C}$			10	mA
$I_{GES}$	Gate Leakage Current	$V_{CE}=0\text{V}, V_{GE} \pm 15\text{V}, T_{VJ}=125^{\circ}\text{C}$	-400		400	nA
$R_{Gint}$	Integrated Gate Resistor			5		$\Omega$
$Q_{ge}$	Gate Charge	$V_{CE}=600\text{V}, I_C=75\text{A}, V_{GE} = \pm 15\text{V}$		0.8		$\mu\text{C}$
$C_{ies}$	Input Capacitance	$V_{CE}=25\text{V}, V_{GE}=0\text{V}, f=1\text{MHz}$		5.1		nF
$C_{res}$	Reverse Transfer Capacitance			0.32		nF
$t_{d(on)}$	Turn - on Delay Time	$V_{CC}=600\text{V}, I_C=75\text{A}, R_G = 7.5 \Omega,$	$T_{VJ} = 25^{\circ}\text{C}$	120		ns
			$T_{VJ} = 125^{\circ}\text{C}$	130		ns
$t_r$	Rise Time	$V_{GE} = \pm 15\text{V},$ Inductive Load	$T_{VJ} = 25^{\circ}\text{C}$	50		ns
			$T_{VJ} = 125^{\circ}\text{C}$	60		ns
$t_{d(off)}$	Turn - off Delay Time	$V_{CC}=600\text{V}, I_C=75\text{A}, R_G = 7.5 \Omega,$	$T_{VJ} = 25^{\circ}\text{C}$	310		ns
			$T_{VJ} = 125^{\circ}\text{C}$	360		ns
$t_f$	Fall Time	$V_{GE} = \pm 15\text{V},$ Inductive Load	$T_{VJ} = 25^{\circ}\text{C}$	20		ns
			$T_{VJ} = 125^{\circ}\text{C}$	30		ns
$E_{on}$	Turn - on Energy	$V_{CC}=600\text{V}, I_C=75\text{A}, R_G = 7.5 \Omega,$	$T_{VJ} = 25^{\circ}\text{C}$	5		mJ
			$T_{VJ} = 125^{\circ}\text{C}$	9		mJ
$E_{off}$	Turn - off Energy	$V_{GE} = \pm 15\text{V},$ Inductive Load	$T_{VJ} = 25^{\circ}\text{C}$	2.6		mJ
			$T_{VJ} = 125^{\circ}\text{C}$	3.8		mJ
$I_{sc}$	Short Circuit Current	$t_{psc} \leq 10\mu\text{s}, V_{GE}=15\text{V}$ $T_{VJ}=125^{\circ}\text{C}, V_{CC}=900\text{V}$		450		A
$R_{thJC}$	Junction-to-Case Thermal Resistance ( Per IGBT )				0.26	K /W
<b>Diode</b>						
$V_F$	Forward Voltage	$I_F=75\text{A}, V_{GE}=0\text{V}, T_{VJ} = 25^{\circ}\text{C}$		2.0		V
		$I_F=75\text{A}, V_{GE}=0\text{V}, T_{VJ} = 125^{\circ}\text{C}$		2.05		V
$t_{rr}$	Reverse Recovery Time	$I_F=75\text{A}, V_R=600\text{V}$		145		ns
$I_{RRM}$	Max. Reverse Recovery Current	$di_F/dt=-2000\text{A}/\mu\text{s}$		95		A
$E_{rec}$	Reverse Recovery Energy	$T_{VJ} = 125^{\circ}\text{C}$		3.8		mJ
$R_{thJCD}$	Junction-to-Case Thermal Resistance ( Per Diode )				0.56	K /W

**NTC SECTOR**

**CHARACTERISTIC VALUES**

*T<sub>c</sub>=25°C unless otherwise specified*

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
R <sub>25</sub>	Resistance	T <sub>c</sub> =25°C		5		KΩ
B <sub>25/50</sub>				3375		K

**MODULE CHARACTERISTICS**

*T<sub>c</sub>=25°C unless otherwise specified*

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
T <sub>vj max</sub>	Max. Junction Temperature				150	°C
T <sub>vj op</sub>	Operating Temperature		-40		125	°C
T <sub>stg</sub>	Storage Temperature		-40		125	°C
V <sub>isol</sub>	Insulation Test Voltage	AC, t=1min		3000		V
CTI	Comparative Tracking Index		250			
Torque	Module-to-Sink	Recommended (M6)	3		5	N· m
Torque	Module Electrodes	Recommended (M5)	2.5		5	N· m
Weight				200		g

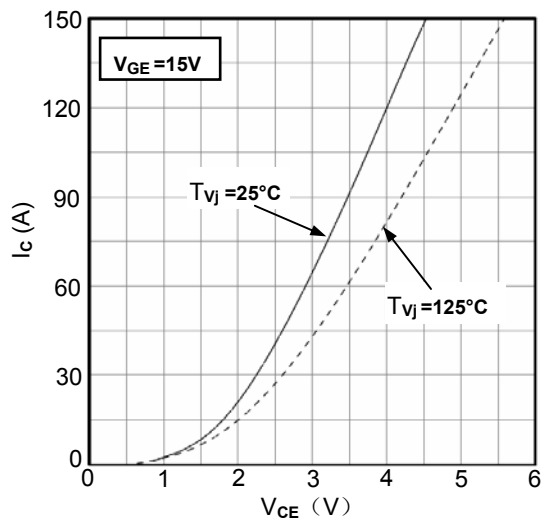


Figure1. Typical Output Characteristics IGBT-inverter

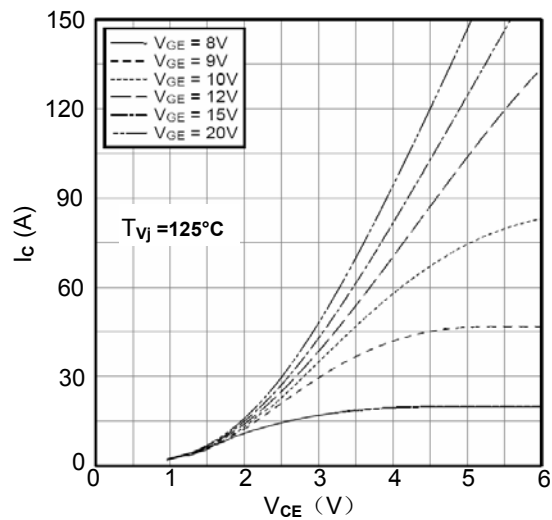


Figure2. Typical Output Characteristics IGBT-inverter

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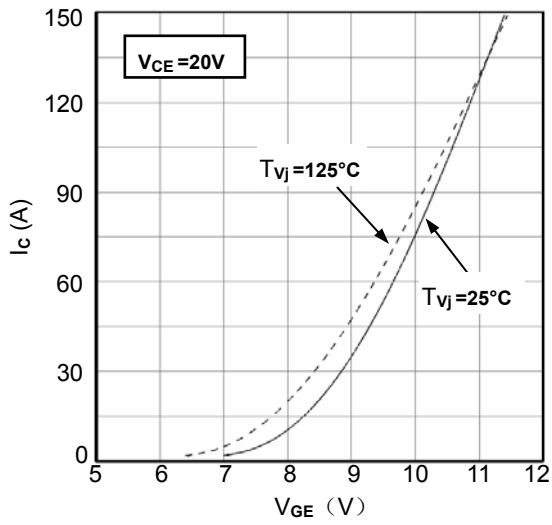


Figure3. Typical Transfer characteristics IGBT-inverter

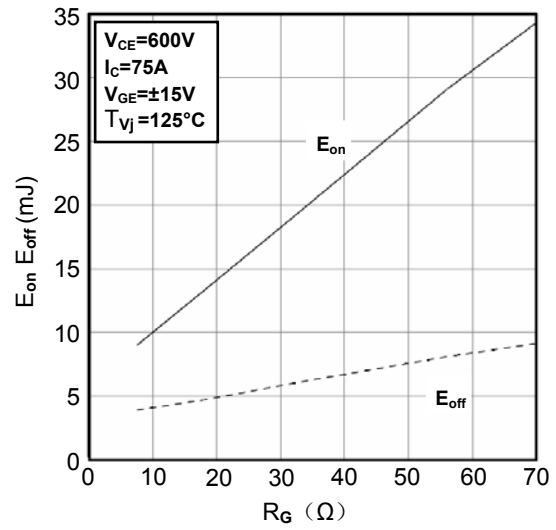


Figure4. Switching Energy vs. Gate Resistor IGBT-inverter

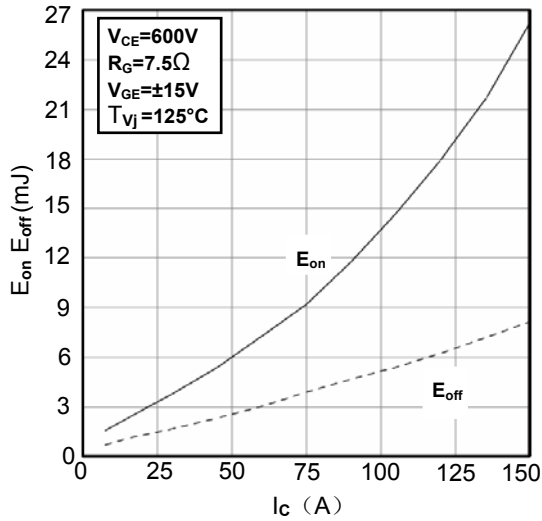


Figure5. Switching Energy vs. Collector Current IGBT-inverter

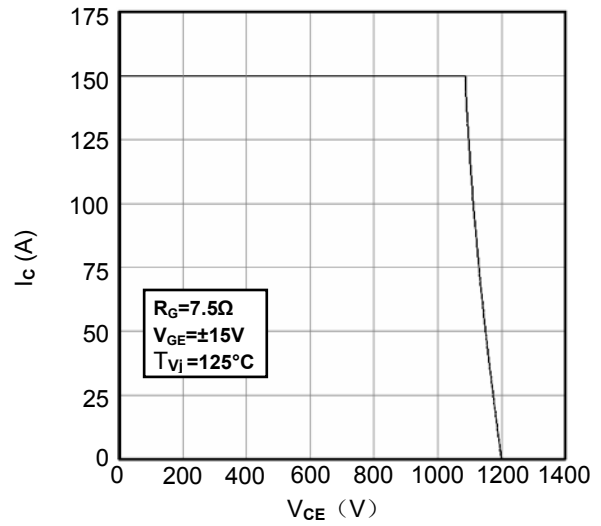


Figure6. Reverse Biased Safe Operating Area IGBT-inverter

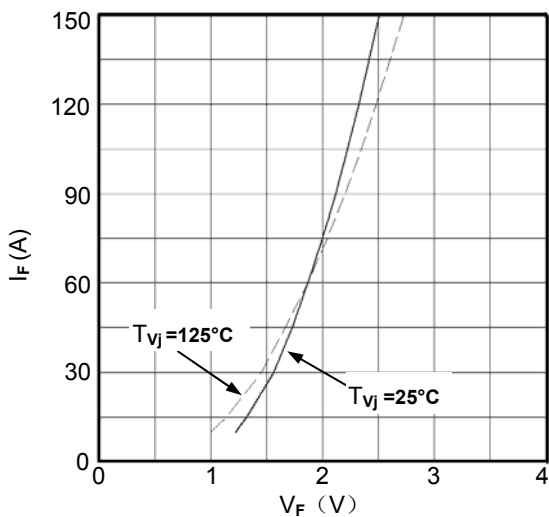


Figure7. Diode Forward Characteristics Diode-inverter

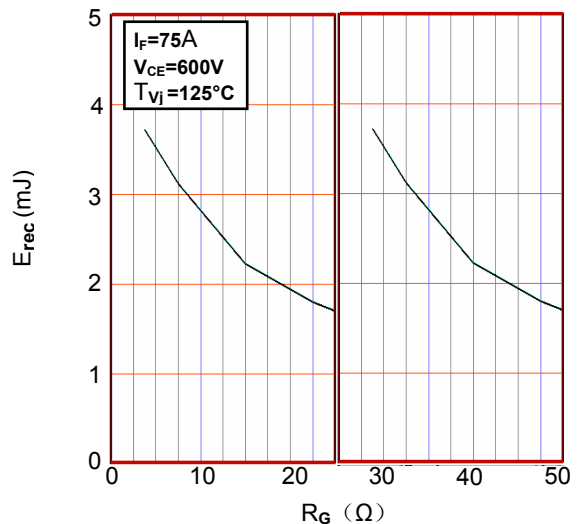


Figure8. Switching Energy vs. Gate Resistor Diode-inverter

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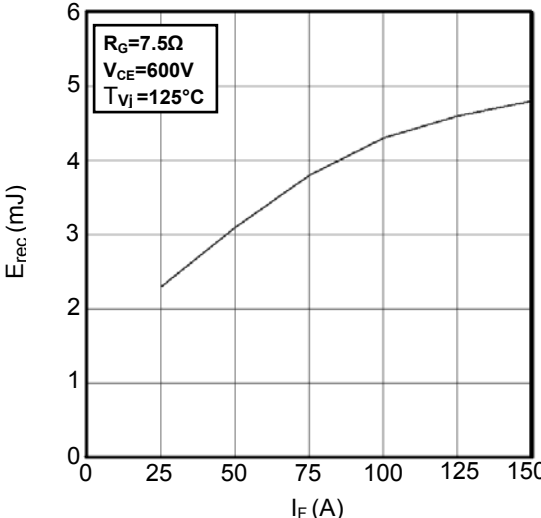


Figure9. Switching Energy vs. Forward Current Diode-inverter

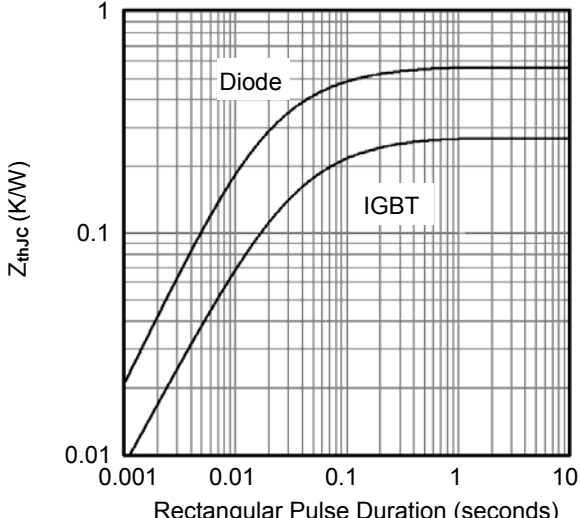


Figure10. Transient Thermal Impedance of Diode and IGBT-inverter

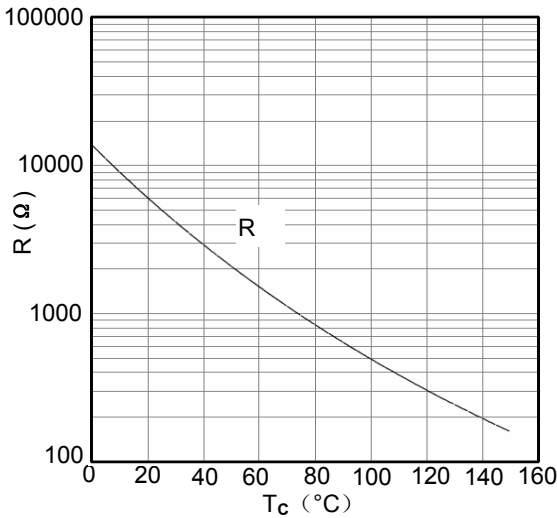


Figure11. NTC Characteristics

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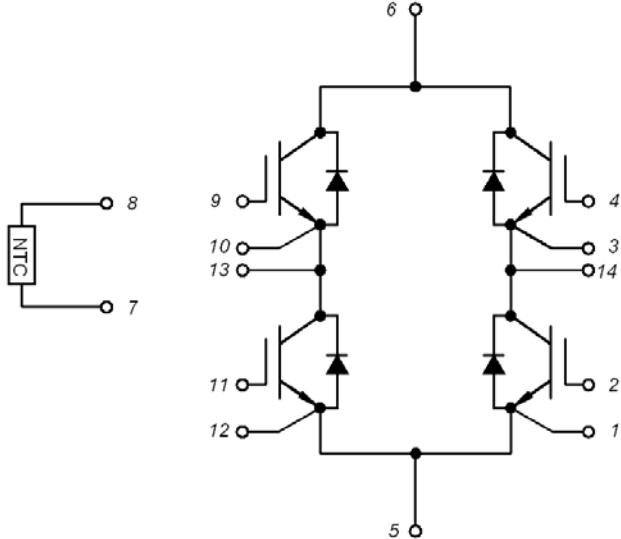
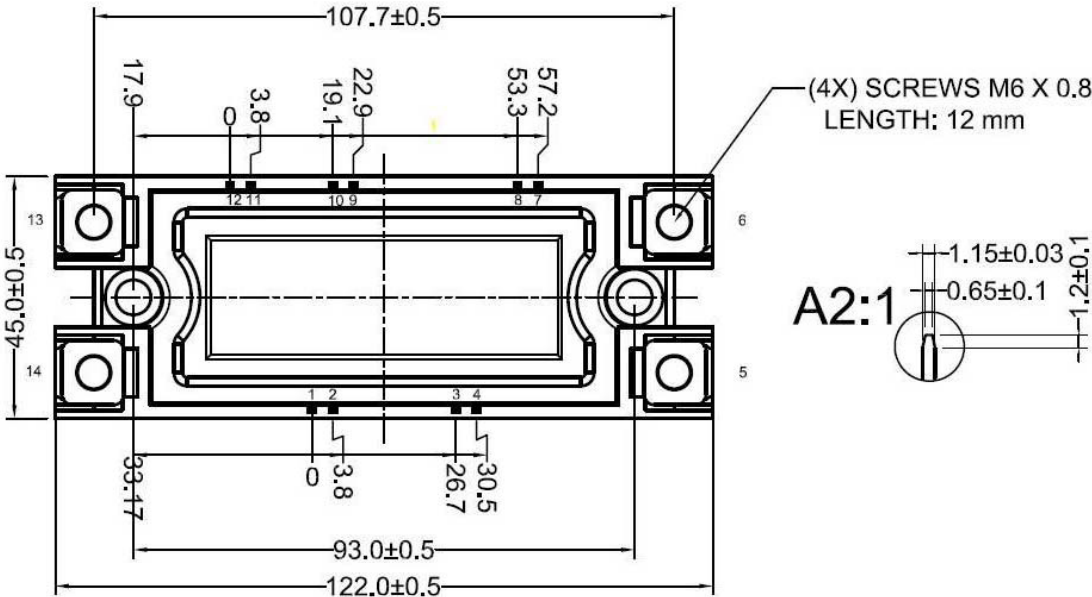
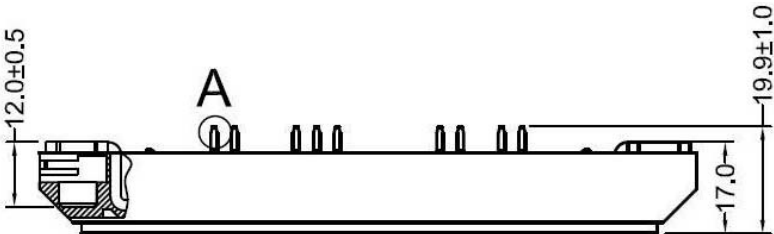


Figure12. Circuit Diagram



Dimensions (mm)  
Figure13. Package Outline